Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,513	CHEN ET AL.	
Examiner	Art Unit	
Carl H. Lavno	3762	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
607	2,4-6,9	7/16/2005	CHL
607	32,59-60	7/16/2005	CHL

SEARCH (INCLUDING SEAR		')
	DATE	EXMR
607/2,4-6,9,32,59-60 (Updated Search in EAST) (See Search History)	7/16/2005	CHL